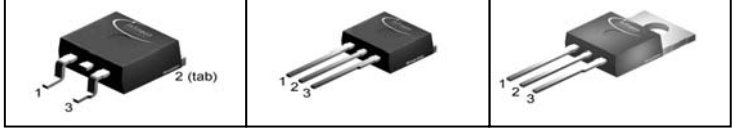
OptiMOS®-P Trench Power-Transistor

Product Summary

V_{DS}	-30	V
$R_{DS(on),max}$ (SMD version)	4	mΩ
I_D	-100	A

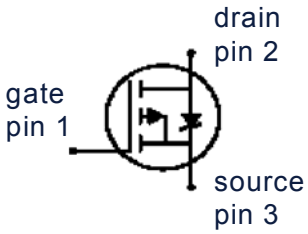
PG-TO263-3-2 PG-TO262-3-1 PG-TO220-3-1



Features

- P-channel - Logic Level - Enhancement mode
- Automotive AEC Q101 qualified
- MSL1 up to 260°C peak reflow
- 175°C operating temperature
- Green package (RoHS Compliant)
- Ultra low Rds(on)
- 100% Avalanche tested
- Intended for reverse battery protection

Type	Package	Marking
IPB100P03P3L-04	PG-TO263-3-2	3P03L04
IPI100P03P3L-04	PG-TO262-3-1	3P03L04
IPP100P03P3L-04	PG-TO220-3-1	3P03L04



Maximum ratings, at T_j=25 °C, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous drain current[1]	I_D	T_C=25°C, V_{GS}=-10V	-100	A
		T_C=100°C, V_{GS}=-10V[2]	-100	
Pulsed drain current[2]	$I_{D,pulse}$	T_C=25°C	-400	
Avalanche energy, single pulse	E_{AS}	I_D=-80A	450	mJ
Gate source voltage	V_{GS}		-16 / +5	V
Power dissipation	P_{tot}	T_C=25°C	200	W
Operating and storage temperature	T_j, T_{stg}		-55 ... +175	°C
IEC climatic category; DIN IEC 68-1			55/175/56	

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Thermal characteristics[2]						
Thermal resistance, junction - case	R_{thJC}		-	-	0.65	K/W
Thermal resistance, junction - ambient, leaded	R_{thJA}		-	-	62	
SMD version, device on PCB	R_{thJA}	minimal footprint	-	-	62	
		6 cm^2 cooling area[3]	-	-	40	
Electrical characteristics, at T_j=25 °C, unless otherwise specified						
Static characteristics						
Drain-source breakdown voltage	$V_{(BR)DSS}$	V_{GS}=0V, I_D=-250µA	-30	-	-	V
Gate threshold voltage	$V_{GS(th)}$	V_{DS}=V_{GS}, I_D=-475µA	-1	-1.5	-2.1	
Zero gate voltage drain current	I_{DSS}	V_{DS}=-30V, V_{GS}=0V, T_j=25°C	-	-0.1	-1	µA
		V_{DS}=-30V, V_{GS}=0V, T_j=125°C[2]	-	-10	-100	
Gate-source leakage current	I_{GSS}	V_{GS}=-16V, V_{DS}=0V	-	-10	-100	nA
Drain-source on-state resistance	$R_{DS(on)}$	V_{GS}=-4.5V, I_D=-50A	-	4.8	7.6	mΩ
		V_{GS}=-4.5V, I_D=-50A, SMD version	-	4.5	7.3	
		V_{GS}=-10V, I_D=-80A	-	3.3	4.3	
		V_{GS}=-10V, I_D=-80A, SMD version	-	3.0	4	

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Dynamic characteristics[2]						
Input capacitance	C_{iss}	V_{GS}=0V, V_{DS}=-25V, f=1MHz	-	7150	9300	pF
Output capacitance	C_{oss}		-	2150	2800	
Reverse transfer capacitance	C_{rss}		-	1650	2500	
Turn-on delay time	$t_{d(on)}$	V_{DD}=-15V, V_{GS}=-10V, I_D=-50A, R_G=6Ω	-	30	-	ns
Rise time	t_r		-	45	-	
Turn-off delay time	$t_{d(off)}$		-	200	-	
Fall time	t_f		-	180	-	
Gate Charge Characteristics[2]						
Gate to source charge	Q_{gs}	V_{DD}=-24V, I_D=-80A, V_{GS}=0 to -10V	-	25	33	nC
Gate to drain charge	Q_{gd}		-	55	82.5	
Gate charge total	Q_g		-	150	200	
Gate plateau voltage	$V_{plateau}$		-	-3.0	-	V
Reverse Diode						
Diode continous forward current[2]	I_S	T_A=25°C	-	-	-100	A
Diode pulse current[2]	$I_{S,pulse}$	T_A=25°C	-	-	-400	
Diode forward voltage	V_{SD}	V_{GS}=0V, I_F=-80A	-0.6	-1	-1.2	V
Reverse recovery time[2]	t_{rr}	V_R=-15V, I_F=-50A, di_F/dt=100A/µs	-	50	-	ns
Reverse recovery charge[2]	Q_{rr}		-	55	-	nC

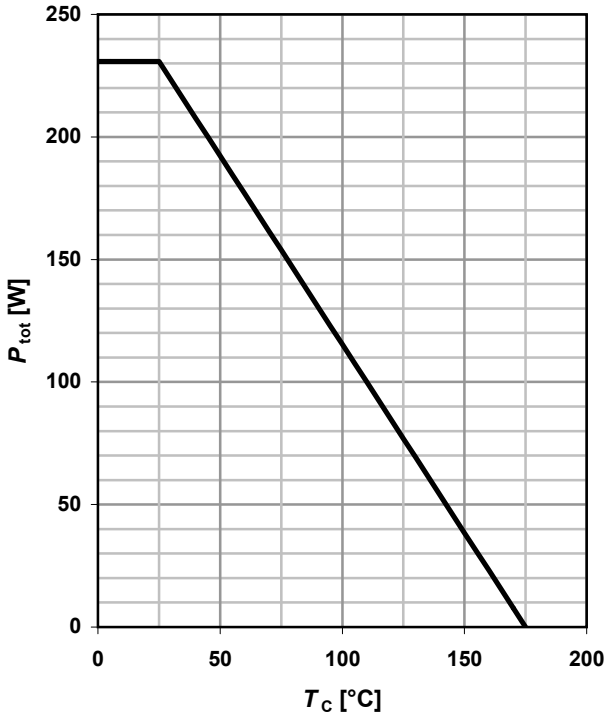
[1] Current is limited by bondwire; with an R_{thJC} = 0.65 K/W the chip is able to carry I_D=-195A at 25°C. For detailed information see Application Note ANPS071E at *www.infineon.com/optimos*

[2] Defined by design. Not subject to production test.

[3] Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm^2 (one layer, 70 µm thick) copper area for drain connection. PCB is vertical in still air.

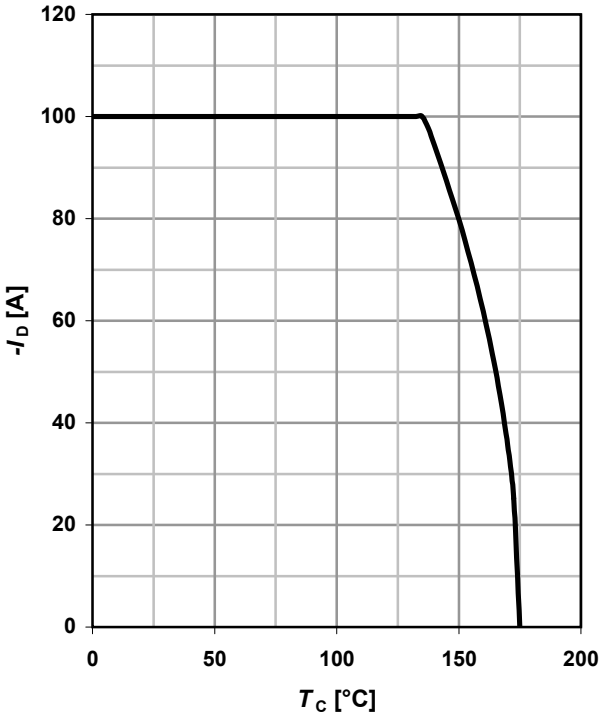
1 Power dissipation

P_{tot}=f(T_C); V_{GS}≤ -4 V



2 Drain current

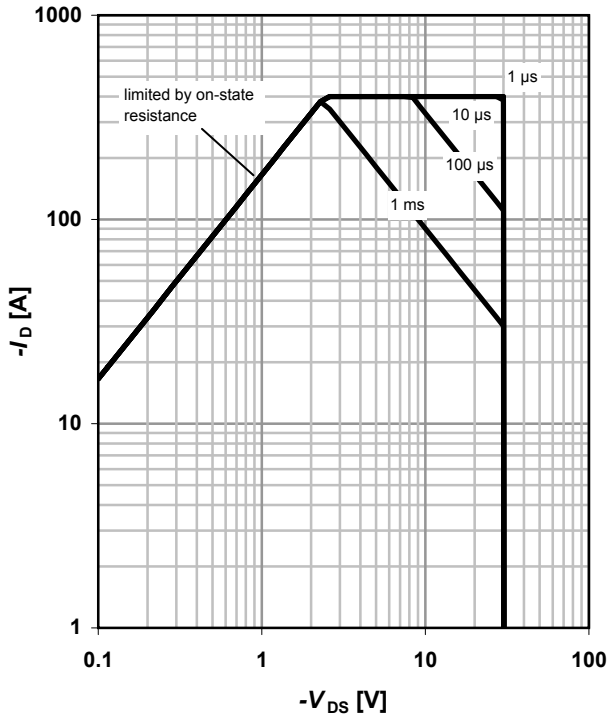
I_D=f(T_C); V_{GS}≤ -4 V



3 Safe operating area

I_D=f(V_{DS}); T_C=25 °C; D=0

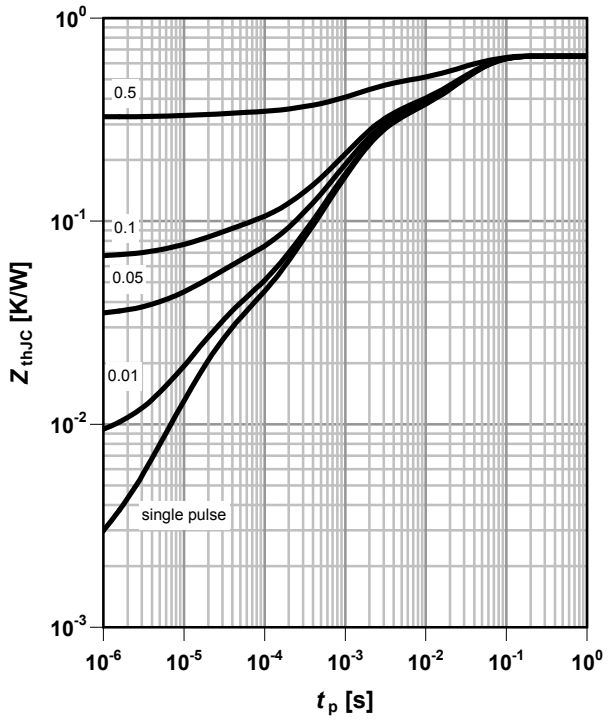
parameter: t_p



4 Max. transient thermal impedance

Z_{thJC}=f(t_p)

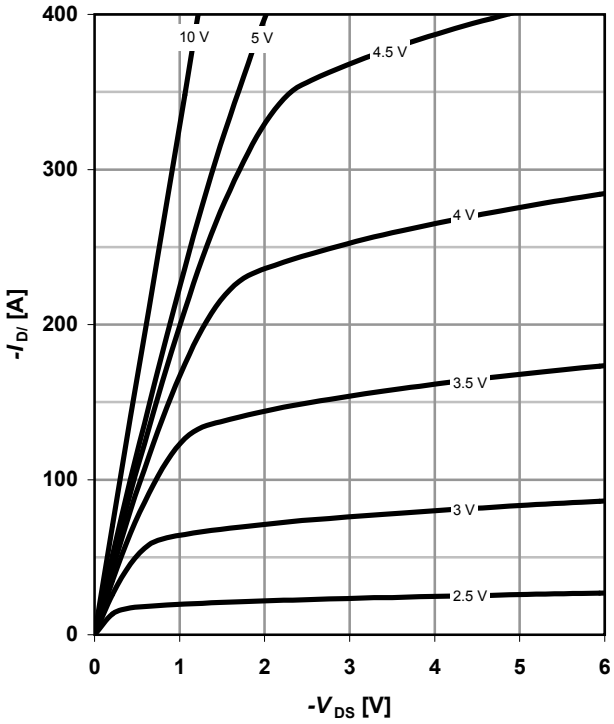
parameter: D=t_p/T



5 Typ. output characteristics

$I_D = f(V_{DS})$; $T_j = 25$ °C

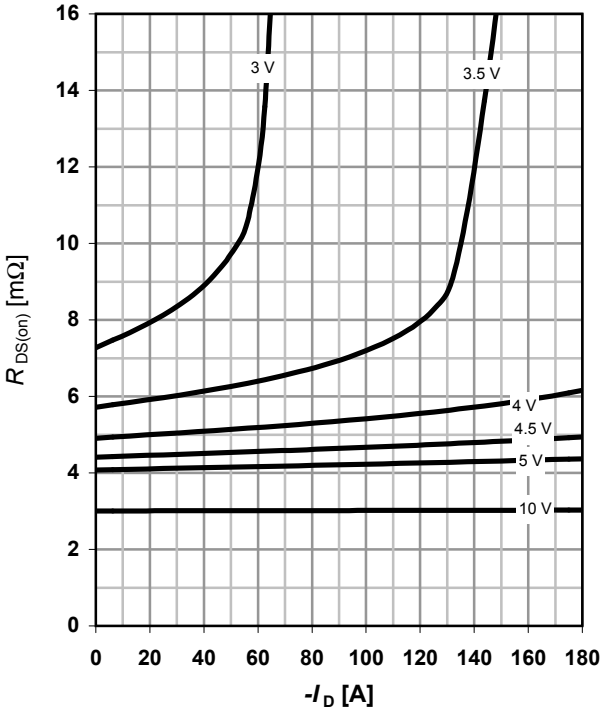
parameter: V_{GS}



6 Typ. drain-source on-state resistance

$R_{DS(on)} = f(I_D)$; $T_j = 25$ °C

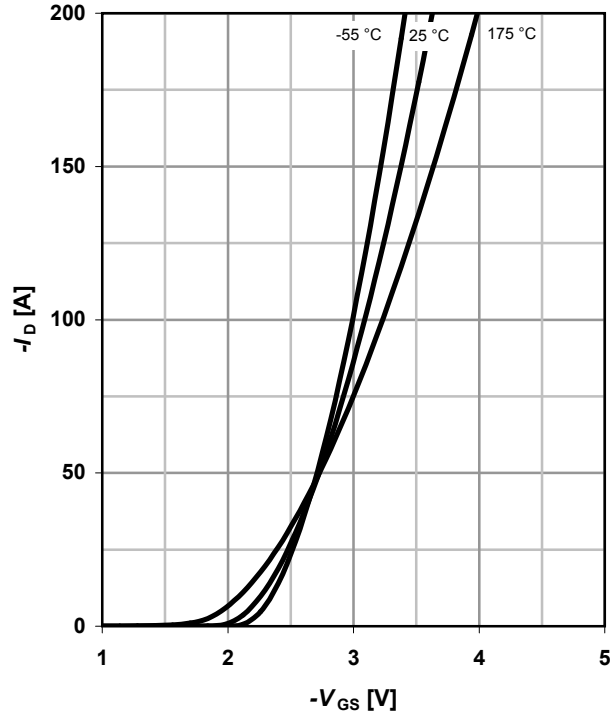
parameter: V_{GS}



7 Typ. transfer characteristics

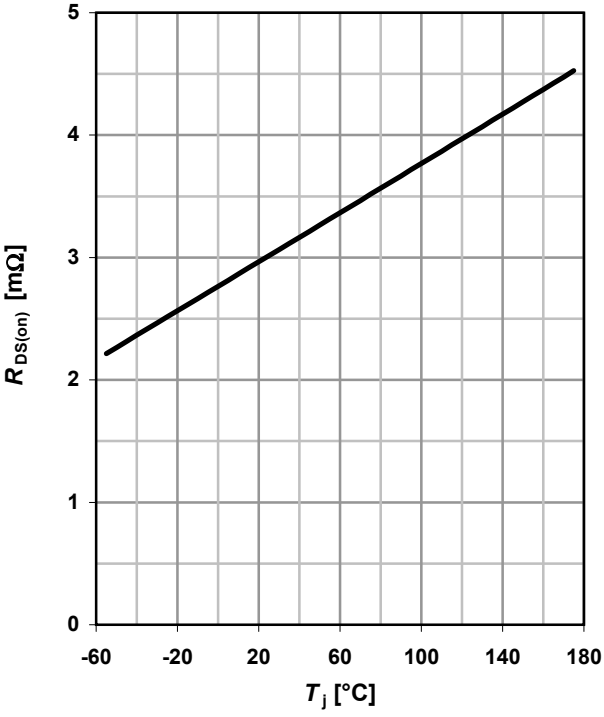
$I_D = f(V_{GS})$; $V_{DS} = 4$V

parameter: T_j



8 Typ. drain-source on-state resistance

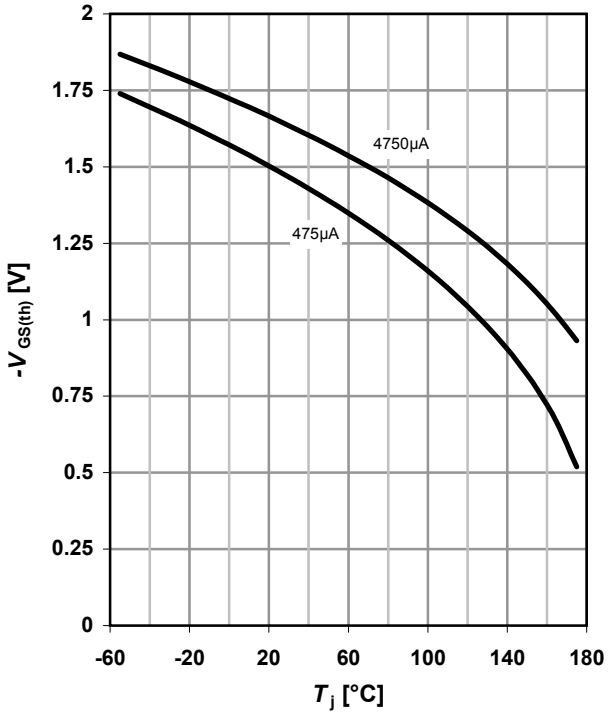
$R_{DS(on)} = f(T_j)$; $I_D = -80$ A; $V_{GS} = 10$ V



9 Typ. gate threshold voltage

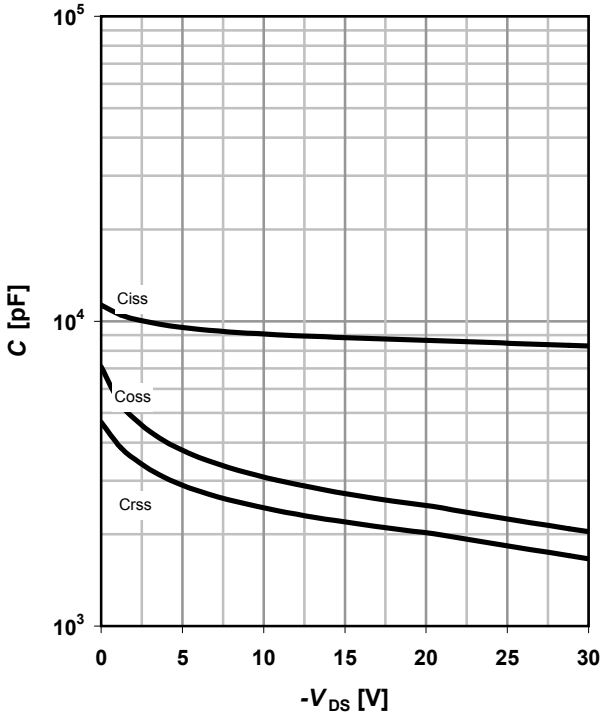
$V_{GS(th)} = f(T_j)$; $V_{GS} = V_{DS}$

parameter: I_D



10 Typ. capacitances

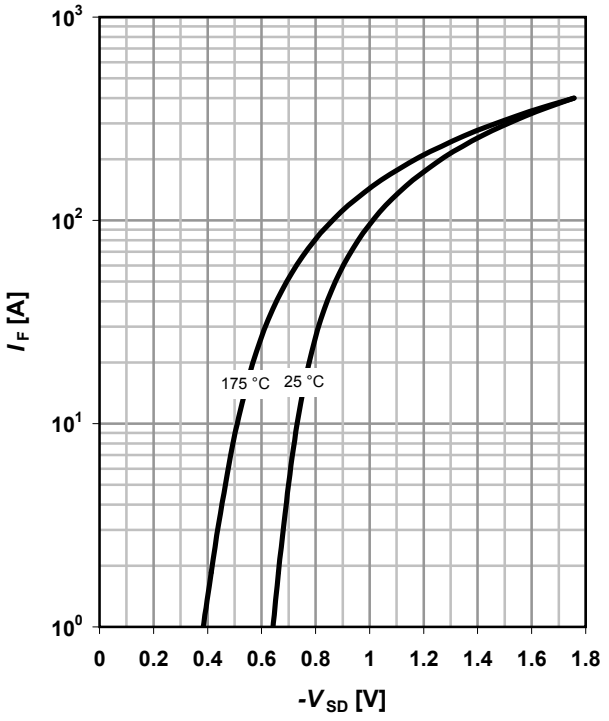
$C = f(V_{DS})$; $V_{GS} = 0$ V; $f = 1$ MHz



11 Typical forward diode characteristicis

IF = f(V_{SD})

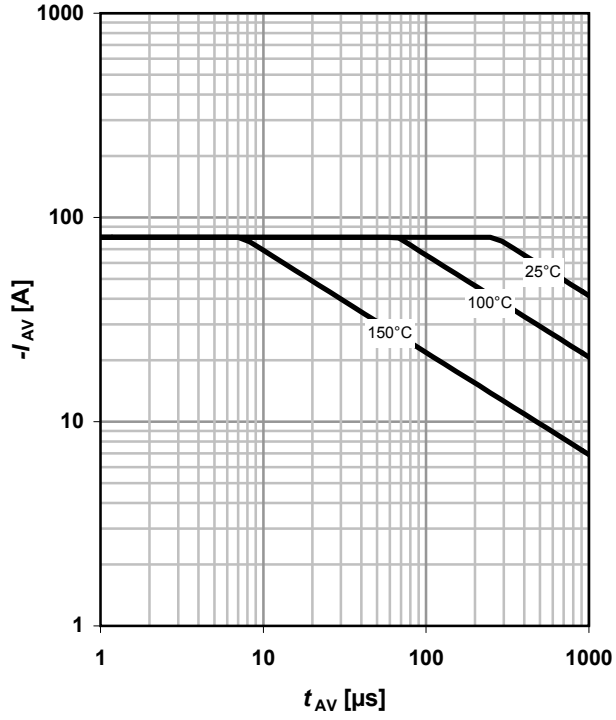
parameter: T_j



12 Typ. avalanche characteristics

$I_{AV} = f(t_{AV})$

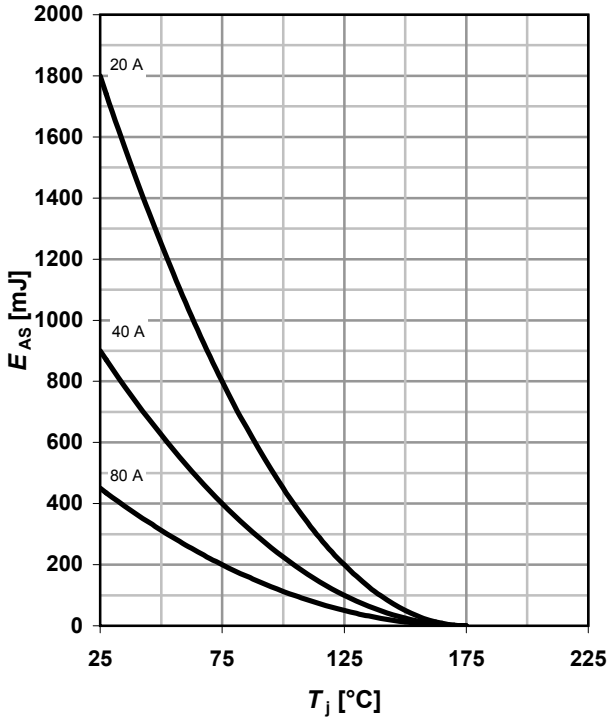
parameter: $T_{j(start)}$



13 Typical avalanche energy

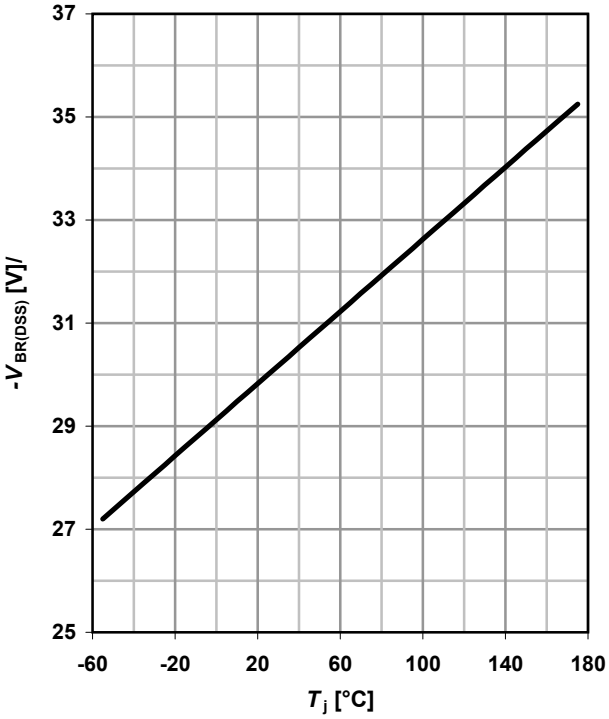
$E_{AS} = f(T_j)$

parameter: I_D



14 Drain-source breakdown voltage

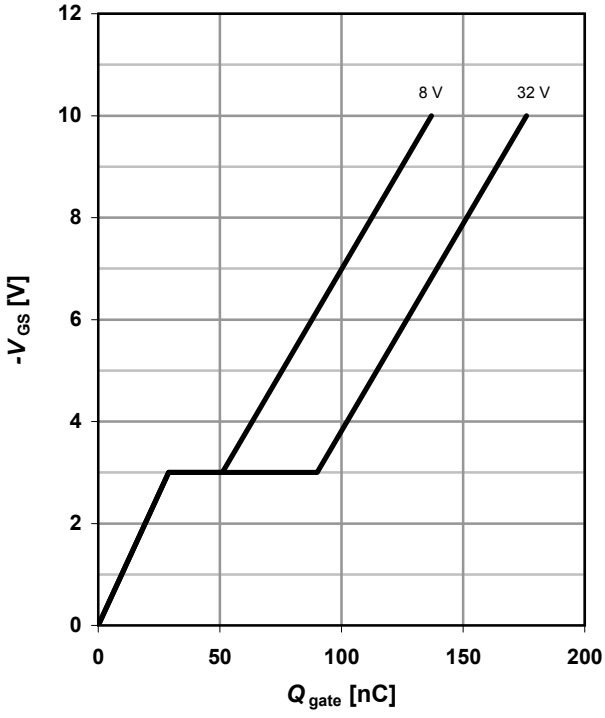
$V_{BR(DSS)} = f(T_j)$; $I_D = 1$ mA



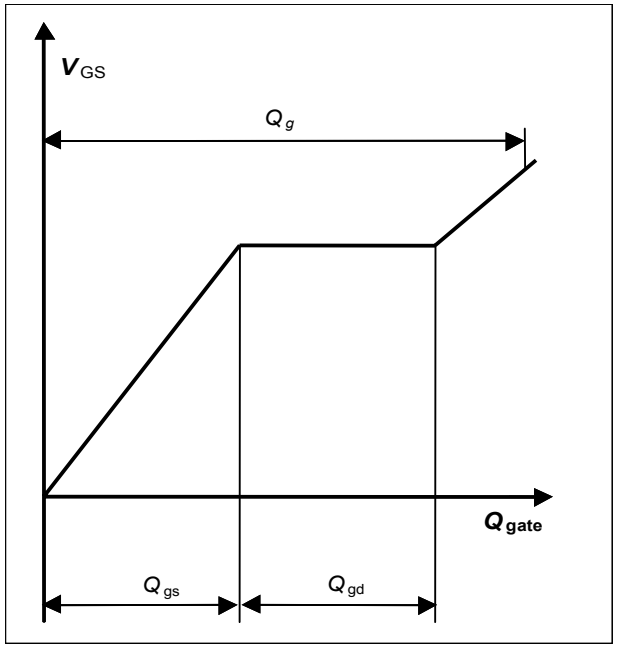
15 Typ. gate charge

$V_{GS} = f(Q_{gate})$; $I_D = 80$ A pulsed

parameter: V_{DD}



16 Gate charge waveforms



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Revision History

Version	Date	Changes
Rev 1.1	25.09.2007	Type on page 1 changed from IP_100P06P3L-04 to IP_100P03PL 04